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Application/Control No.	Applicant(s)/Patent under Reexamination	
09/900,674	NYHAN ET AL.	
Examiner	Art Unit	_
Beth Van Doren	3623	

SEARCHED			
Class	Subclass	Date	Examiner
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INTERFERENCE SEARCHED			
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SEARCH NOT (INCLUDING SEARCH		)
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East Update (US, JPAB, EPAB, Derwent, IBM_TD, PGPub)	4/14/2006	and
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